MONDAY, 7 MAY 2001

8:30am - 12:00pm

TUTORIALS & WORKSHOPS

- I. Life Cycle Assessment and Design for Environment: Useful Electronics Applications
 - Harald Florin, PE Group
 - Andrea Russell, Five Winds International

II. Transition to Lead-Free Solder in Electronics

- Karl J. Puttlitz, IBM Corporation
- Kathleen A. Stalter, IBM Corporation
- Mohammad Yunus, Texas Instruments
- Carol Handwerker, National Institute of Standards and Technology

III. International and Domestic Regulatory Product Requirements for the Electronic Sector

- Paul Hagen, Beveridge & Diamond, P.C.
- William F. Hoffman III, Motorola Advanced Technology Center
- Heather Bowman, Electronic Industries Alliance

12:00pm - 1:00pm

LUNCH FOR MONDAY SPEAKERS

1:15p.m. – 2:15p.m.

Plenary Speaker

Wayne S. Balta, Director, Corporate Environmental Affairs, IBM Corporation

2:30 p.m. - 4:30 p.m.

Session 1

DFE Methodology & Tools I

Chair: Duncan Noble, Five Winds International

Eco-Labelling and the Information Technology (IT) Industry

Ferdinand Hermann, Compaq Computer EMEA BV

Hans-Peter Urbach, Siemens AG

Hans Wendschlag, Hewlett Packard Sverige AB

Measuring Material Cycling in Industrial Systems

Reid Bailey, University of Dayton

Bert Bras, Georgia Institute of Technology

Janet Allen, Georgia Institute of Technology

Disassembly Complexity and Recyclability Analysis of New Designs from CAD File Data

Vishakar Mani, New Jersey Institute of Technology Sanchoy Das, New Jersey Institute of Technology Reggie Caudill, New Jersey Institute of Technology

Development of a CAD Integrated DFE Workbench Tool

Thomas Roche, Galway Mayo Institute of Technology Elena Man, National University of Ireland Jimmie Browne, National University of Ireland

2:30 p.m. - 4:30 p.m.

Session 2

Manufacturing Processes I

Chair: Surendra Gupta, Northeastern University

The Quest for Environmental and Productivity Improvements at the IBM Demanufacturing and Asset Recovery Center

Ed Grenchus, IBM Corporation Robert Keene, IBM Corporation Charles Nobs, IBM Corporation Larry Yehle, IBM Corporation

Flexible Disassembly Tools

- G. Seliger, Technical University Berlin
- T. Keil, Technical University Berlin
- U. Rebafka, Technical University Berlin
- A. Stenzel, Technical University Berlin

Product Recovery Using a Disassembly Line: Challenges and Solution

Surendra M. Gupta, Northeastern University Aşkıner Güngör, Pamukkale University

Cathode Ray Tube Manufacturing and Recycling: Analysis of Industry Survey

- A. Monchamp, Electronic Industries Alliance
- H. Evans, Electronic Industries Alliance
- J. Nardone, Electronic Industries Alliance
- S. Wood, Electronic Industries Alliance
- E. Proch, Electronic Industries Alliance
- T. Wagner, Electronic Industries Alliance

2:30 p.m. - 4:30 p.m.

Session 3

Corporate Strategies for Environmental Performance

Chair: Dani Tsuda, Apple

Product Environmental Care, a Praxis-Based System Uniting ISO 14001, ISO 14062, IPP, EEE and Ecolabel Elements

Ab Stevels, Delft University of Technology

Product and Process Life Cycle Inventories using SAP R/3

Antje Januschkowetz, Robert Bosch GmbH

Chris T. Hendrickson, Carnegie Mellon University

An IBM Methodology for Evaluating Emerging Requirements

Anne Brinkley, IBM Corporation Mary Ann Christie, IBM Corporation Mary Jacques, IBM Corporation J. Ray Kirby, IBM Corporation Tim Mann, IBM Corporation

Stakeholder Dialogues on Recycling Engineering Thermoplastics: A Collaborative Effort to Build a Recycling Infrastructure for Plastics from Electronics

Patricia S. Dillon, Gordon Institute at Tufts University

4:45 p.m. - 5:45 p.m. ROUNDTABLE DISCUSSIONS

TUESDAY, 8 MAY 2001

8:30a.m. – 9:45a.m.

KEYNOTE ADDRESS

Jonathan G. Koomey, Staff Scientist, Lawrence Berkeley National Laboratory

10:00 a.m. - 12:00 p.m.

Session 4

DFE Assessment Methods

Chair: Hong-Chao Zhang, Texas Tech University

Ranking Ecodesign Priorities from Quantitative Uncertainty Assessment for End-of Life Scenarios

Casper Boks, Delft University of Technology Ab Stevels, Delft University of Technology

Optimization of Inductive RFID Technology

Steve C.Q. Chen, Princeton University Valerie Thomas, Princeton University

Calculating Environmentally Weighted Recyclability of Consumer Electronic Products using Different Environmental Assessment Models

Jaco Huisman, Delft University of Technology Ab Stevels, Delft University of Technology

Andreas Middendorf, Fraunhofer IZM

Comparison of Major Environmental Performance Metrics and Their Application to Typical Electronic Products

Yanchun Luo, New Jersey Institute of Technology Pornsarun Wirojanagud, New Jersey Institute of Technology Reggie J. Caudill, New Jersey Institute of Technology

10:00 a.m. - 12:00 p.m.

Session 5

End of Life Strategies

Chair: Richard VanLandingham, Texas Instruments

Metrics for End-of-Life Strategies (ELSEIM)

Catherine M. Rose, Delft University of Technology Ab Stevels, Delft University of Technology

End of Life Recycling through Free Enterprise

Douglas Smith, Sony Electronics Inc. Mark Small, Sony Electronics Inc.

An Overview of IBM Product Takeback Programs: "Considerations for Commercial and Consumer Computer Returns"

Rhea Hale, IBM Corporation
J. Ray Kirby, IBM Corporation
Timothy Mann, IBM Corporation
Dewey Pitts, IBM Corporation

A Logistic Concept to Improve the Re-usability of Electric and Electronic Equipment

Reinhard Knoth, Austrian Society for Systems Engineering and Automation Martina Hoffmann, Austrian Society for Systems Engineering and Automation Bernd Kopacek, Austrian Society for Systems Engineering and Automation Peter Kopacek, Austrian Society for Systems Engineering and Automation

10:00 a.m. - 12:00 p.m.

Session 6

Life Cycle Impact Assessment

Chair: David Dickinson, Lucent Technologies

Life-Cycle Environmental Impacts of CRT and LCD Desktop Monitors

Maria Leet Socolof, University of Tennessee Jonathan G. Overly, University of Tennessee Lori E. Kincaid, University of Tennessee Rajive Dhingra, University of Tennessee Dipti Singh, US Environmental Protection Agency Katherine M. Hart, US Environmental Protection Agency

Life Cycle Assessment of an Integrated Circuit Product

Fulvio Taiariol, CSELT Patrizia Fea, CSELT Claudio Papuzza, CSELT Raffaella Casalino, Politecnico di Torino Enrico Galbiati, STMicroelectronics Stefano Zappa, STMicroelectronics

Energy Consumption of Cellular Telephones

Ion V. Nicolaescu, Motorola Advanced Technology Center William F. Hoffman, Motorola Advanced Technology Center

Life Cycle Profitability Analysis and LCA by Simulating Material and Money Flows

Takeshi Murayama, Hiroshima University Shinya Hatakenaka, Hiroshima University Norihiko Narutaki, Hiroshima University Fuminori Oba, Hiroshima University

12:00 p.m. – 1:45 p.m.

LUNCHEON ADDRESS

Dr. Robert C. Pfahl, Jr., Director of International & Environmental Research & Development, Motorola Advanced Technology Center

2:00 p.m. - 3:30 p.m.

PANEL: Environmental Implications of E-commerce

Panel Members:

H. Scott Matthews Carnegie Mellon University

Reggie Caudill New Jersey Institute of Technology

Mark Greenleaf Ford Motor Company

3:45 p.m. - 5:15 p.m.

Session 7

DFE Methodology & Tools II

Chair: Li Shu, University of Toronto

Life Cycle Inventory Analysis and Identification of Environmentally Significant Aspects in Semiconductor Manufacturing

Karsten Schischke, Technische Universität Berlin

Markus Stutz, Motorola GmbH

Jean-Paul Ruelle, Motorola SA

Hansjörg Griese, Fraunhofer-Institut für Zuverlässigkeit und Mikrointegration (IZM)

Herbert Reichl, Technische Universität Berlin

A System for Integrating Design for Environment (DFE) Criteria into the New Product Introduction Process

Tom L. Neal, Hewlett-Packard Mark Heintz, Hewlett-Packard

A Semi-Quantitative Methodology of Environmentally Conscious Design for

Electromechanical Products

Xueqing Qian, Texas Tech University Yue Yu, I2 Technologies Hong-chao Zhang, Texas Tech University

3:45 p.m. - 5:15 p.m.

Session 8

Advanced Electronic Technologies & Modeling

Chair: Demi Tomita, Sony Corporation

Remanufacturing - the Key Solution for Transforming "Downcycling" into "Upcycling" of Electronics

Rolf Steinhilper, University of Bayreuth Martin Hieber, Fraunhofer Institute IPA

Fuzzy Reasoning Petri Nets for Demanufacturing Process Decision

Meimei Gao, New Jersey Institute of Technology MengChu Zhou, New Jersey Institute of Technology

A Systematic Approach to Disassembly Line Design

Ying Tang, New Jersey Institute of Technology MengChu Zhou, New Jersey Institute of Technology Reggie Caudill, New Jersey Institute of Technology

3:45 p.m. - 5:15 p.m.

Session 9

Analysis of the Impacts of E-everything

Chair: Sanchoy Das, New Jersey Institute of Technology

Web-Based Tool for Estimating the Environmental Impacts of Telework

Erasmia Kitou, University of California at Berkeley Eric Masanet, University of California at Berkeley Arpad Horvath, University of California at Berkeley

Network-Based Optimization and Simulation of Sustainable E-Supply Chain Management

Yanchun Luo, New Jersey Institute of Technology Pornsarun Wirojanagud, New Jersey Institute of Technology Reggie J. Caudill, New Jersey Institute of Technology

The Net Effect: Environmental Implications of E-Commerce and Logistics

H. Scott Matthews, Carnegie Mellon University Chris T. Hendrickson, Carnegie Mellon University Denise Soh, Carnegie Mellon University

WEDNESDAY, 9 MAY 2001

8:00 a.m. - 9:30 a.m. Session 10

DFE in Practice

Chair: David Ufford, Raytheon

Product Ecology at Intel

Todd A. Brady, Intel Corporation Nancy L. Sumrall, Intel Corporation Vivek Gupta, Intel Corporation Allen M. Frishman, Intel Corporation

Accompanying the (re)design of Products with Environmental Assessment (DfE) on the Example of ADSM

N. Warburg, University of Stuttgart C. Herrmann, University of Stuttgart J.D. Chiodo, Brunel University

The Evolution of Design for Environment in Electronics Firms

James Fava, Five Winds International Duncan Noble, Five Winds International Andrea J. Russell, Five Winds International

8:00 a.m. - 9:30 a.m.

Session 11

Advancing Electronic Technologies & Modeling

Chair: John Lott, DuPont & Technologies

Implementing the WEEE Directive

Klaus Hieronymi, Hewlett-Packard Europe

Value Added Color Sorting of Recycled Plastic Flake from End-of-Life Electrical and Electronic Equipment

Brian L. Riise, MBA Polymers L.E. Allen, MBA Polymers Michael B. Biddle, MBA Polymers Michael M. Fisher, American Plastics Council

Economic and Logistical Modeling for Regional Processing and Recovery of Engineering Thermoplastics

Cynthia F. Murphy, University of Texas at Austin

Patricia S. Dillon, Tufts University

Gregory E. Pitts, Ecolibrium

8:00 a.m. - 9:30 a.m.

Session 12

Closed Loop Supply Chain Management

Chair: MengChu Zhou, New Jersey Institute of Technology

Improving Environmental Performance Through Reverse Logistics at IBM

Ed Grenchus, IBM Corporation

Shirley Johnson, IBM Corporation

Dan McDonnell, IBM Corporation

The DBOM Standard: A Specification for Efficient Product Data Transfer Between Manufacturers and Demanufacturers

Sanchoy Das, New Jersey Institute of Technology Sandeep Naik, New Jersey Institute of Technology

9:45 a.m. - 11:45 a.m.

Session 13

DFE Metrics & Implementation

Chair: Laurence Weinberg, Boeing

A Web-enabled Virtual Disassembly Manager (webVDM) for Electronic Products

Paul G. Ranky, New Jersey Institute of Technology

Reggie J. Caudill, New Jersey Institute of Technology

Sanchoy K. Das, New Jersey Institute of Technology

Apoorva Bhatia, New Jersey Institute of Technology

Satishkumar Chamyvelumani, New Jersey Institute of Technology

Assessing Product Design Alternatives with Respect to Environmental Performance and Sustainability: A Case Study for Circuit Pack Faceplates

- J. Mosovsky, Agere Systems
- J. Dispenza, Lucent Technologies
- D. Dickinson, Lucent Technologies
- J. Morabito, Lucent Technologies
- R. Caudill, New Jersey Institute of Technology
- N. Alli, New Jersey Institute of Technology

Supply Chain Management: From Strategy to Implementation

Steven B. Young, Five Winds International

Duncan Noble, Five Winds International

Andrea J. Russell, Five Winds International

How Can Experiences From Reuse Activities Influence the Development of DFE-Tools

- M. Hoffmann, Austrian Society for Systems Engineering and Automation
- R. Knoth, Austrian Society for Systems Engineering and Automation
- B. Kopacek, Austrian Society for Systems Engineering and Automation
- P. Kopacek, Austrian Society for Systems Engineering and Automation

9:45 a.m. - 11:45 a.m.

Session 14

Product Reuse & Recycling Chair: Lee Goldberg, Chip Center

Method to Assess the Recyclability of Televisions from the Perspective of Consumer Organisations

Kim Janssen, TNO Industrial Technology Ab Stevels, Delft University of Technology

Environmental Impact of a Telecommunication Service

Fulvio Taiariol, CSELT Patrizia Fea, CSELT Claudio Papuzza, CSELT Alberto Ramella, Politecnico di Torino

Analysis of Remanufacturer Waste Streams for Electronic Products

J. Williams, University of Toronto

L.H. Shu, University of Toronto

Reliability of Lead Free Solder Joint by Using Chip Size Package

- T. Hirano, Sony Corporation
- K. Fukuda, Sony Corporation
- K. Ito, Sony Corporation
- T. Kiga, Sony Corporation
- Y. Taniguchi, Sony Corporation

9:45 a.m. - 11:45 a.m.

Session 15

Environmental Analysis of Electronic Materials

Chair: J. Ray Kirby, IBM Corporation

Lead-Free Soldering - Toxicity, Energy and Resource Consumption

- O. Deubzer, University of Tokyo
- H. Hamano, University of Tokyo
- T. Suga, University of Tokyo
- H. Griese, Fraunhofer IZM

The Development of Lead-Free Printed Circuit Assembly Technology in Hewlett-Packard: Our Strategy and Experience

Gregory A. Henshall, Hewlett-Packard Co. Lisa W. Lindsley, Hewlett-Packard Co.

Eco-Comparison Between Ceramic and Epoxy Based Populated PWBs

C. Herrmann, University of Stuttgart J. Gediga, PE Product Engineering

N. Warburg, University of Stuttgart

Survey of Alternatives to Tin-Lead Solder and Brominated Flame Retardants

Cynthia F. Murphy, University of Texas at Austin

Gregory E. Pitts, Ecolibrium